# n-type silicon pad array detector test at PS, CERN

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# Outline

- Test setup
- Noise estimation
- Response to pion beam
  - $\circ$  MIP signal
  - Detector operating voltage scan
  - $\circ$  Gain correction
- Response to electron beam
  - $\circ$  Longitudinal shower profile
  - Transverse energy profile
- Summary

# Tests beam setup at PS CERN



- W plates ~ 1 radiation length, placed behind the detector
- Si pad array coupled with HGCROCv2 PCB
- PCB connected to KCU105 board via interface board

Energy in GeV			
5, 10, 15			
1, 2, 3, 4, 5			
0, 1, 2, 3, 4, 5, 6, 8			

# Tests beam setup at PS CERN: Trigger Scheme

- Trigger: AND logic of Cherenkov and plastic scintillators
- Cherenkov not used for pion beam (>90% purity above 5 GeV pion)





#### Geant4 test beam simulations



5

# Typical noise distribution

#### Pedestal distribution of 4 channels in detector



Pedestal follows gaussian distribution

#### Pedestal mean and rms value for all 72 channels

Mean pedestal ~ 174 ADC

#### Detector response to pion beam: MIP



- 10 GeV  $\pi^-$  beam focused on one of the pad of detector
- Pedestal mean plus 3 sigma noise subtraction

A clear pion MIP signal is obtained, described by Landau function

#### Detector response to pion beam: MIP



### Detector response to pion beam: voltage scan



### Detector response to pion beam: Position scan

10 GeV pion beam focused on different channels during the position scan



#### Position Scan: Detector gain correction



#### Detector response to e<sup>-</sup> beam: MIP

#### Data taken without any absorber plate before detector



Both electron and pion mip from data has broader peaks than simulations due to noise

### Electromagnetic cascades

A high energy electron or photon, incident on a thick absorber initiates an electromagnetic cascade through bremsstrahlung and pair production

> Longitudinal shower development scales with radiation length

Electrons eventually fall beneath critical energy and lose further energy through dissipation and ionization



#### Detector response to e<sup>-</sup> beam: Hit map



Electron-positron cascade is relatively narrow at 2 X<sub>0</sub> than 6 X<sub>0</sub>

# Detector response to e<sup>-</sup> beam: Clustering algorithm

The algorithm focuses on identifying clusters of pads that are adjacent or connected to each other on the silicon detector



### Detector response to e<sup>-</sup> beam: Cluster ADC distribution

- Energy deposited by electrons (ADC) across 3 and 5 radiation lengths
- Clustering algorithm used to sum the energy across the pads in cluster



Energy deposition increases with increased electron energy

#### Detector response to e<sup>-</sup> beam: Energy calibration

Linear trend is observed between the deposited energy in data (ADC) and simulations (MeV)



Energy deposition increases with increase in electron energy



#### Detector response to e<sup>-</sup> beam: Longitudinal shower profile

Higher energy particles push "shower maximum" deeper into the material (radiation length)



Mean cluster size represents the transverse dimension of electromagnetic showers



#### Detector response to e<sup>-</sup> beam: Transverse energy profile

#### What causes transverse spread?

- Finite opening angle between the  $e^-e^+$  pair.
- Multiple scattering between electrons.

90 % of the total energy deposited, remains within 1 molar radius



experiments. Springer Science & Business Media, 2012.

### Detector response to e<sup>-</sup> beam: Transverse energy profile



# Summary

- Clear MIP peak observed for 5 GeV, 10 GeV, and 15 GeV  $\pi^-$  beams at various positions on the Si pad array.
- Detector bias voltage scan using the pion beam determined the operating voltage.
- Gain correction performed to achieve uniform gain across all channels of the detector.
- Energy calibration is done to convert the deposited energy from ADC to MeV.
- Longitudinal shower profile for 1 GeV to 5 GeV electron showers with 0 to 8 tungsten plates is generated which is in agreement with the Geant4 simulations.
- Calculation of molar radius using the transverse shower profile of electrons

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# Backup slides

#### Mean energy loss: Bethe-Bloch



# Typical noise distribution: 72 Channels

ch 32	ch 34	ch 35	ch 27	ch 63	ch 71	ch 70	: 175
Mean: 173	Mean: 173	Mean: 164	Mean: 176	Mean: 175	Mean: 171	Mean: 173	
ch 30	ch 28	ch 33	ch 31	ch 67	ch 65	ch 64	: 178
Mean: 175	Mean: 177	Mean: 174	Mean: 174	Mean: 171	Mean: 171	Mean: 173	
ch 29	ch 26	ch 25	ch 23	ch 57	ch 55	ch 60	: 178
Mean: 177	Mean: 172	Mean: 174	Mean: 164	Mean: 174	Mean: 177	Mean: 175	
ch 20	ch 24	ch 21	ch 19	ch 61	ch 59	ch 62	: 184
Mean: 177	Mean: 174	Mean: 169	Mean: 170	Mean: 178	Mean: 174	Mean: 172	
ch 18 Mean: 175	ch 22 Mean: 175	ch 17 Mean: 172	ch 16 Mean: 171	ch 52 Mean: 170	ch 50 Mean: 172	ch 56 Mean: 175 Mean	: 175
ch 13	ch 15	ch 10	ch 14	ch 48	ch 46	ch 51	: 173
Mean: 179	Mean: 181	Mean: 175	Mean: 171	Mean: 173	Mean: 167	Mean: 175	
ch 12 Mean: 158	ch 9 Mean: 171	ch 11 Mean: 176	ch 0 Mean: 175	ch 36 Mean: 174	ch 45 Mean: 170	ch 47 Mean: 173 Mean	: 171
ch 5 Mean: 172	ch 3 Mean: 174	ch 6 Mean: 166	ch 4 Mean: 175	ch 40 Mean: 174	ch 42 Mean: 172	ch 37 Mean: 171 ch 41 Mean	: 178
ch 7 Mean: 167	ch 1 Mean: 174	ch 2 Mean: 175	ch 8 Mean: 151	ch 44 Mean: 175	ch 38 Mean: 176	ch 39 Mean: 176 de Aa Mean	; .: 169

- Pedestal distribution for all 72 channels
  Pedestal fit
- Pedestal fit with gaussian function

# Typical noise distribution: Multiple background data



# Typical noise distribution: Detector OFF

- Pedestal distribution of 4 channels in detector
- Pedestal is fit with gaussian function



- Pedestal mean value for 72 channels
- Bias voltage: 60V
- Mean pedestal ~ 173 ADC



# Typical noise distribution: Multiple background data





Same pedestal mean value is observed with bias voltage on and off

### Detector operating voltage: CV plot



### Pion MIP: Position scan data (after calibration)



#### Detector response to e<sup>-</sup> beam: Cluster ADC distribution

• Energy deposited by electrons in MeV values across 5 radiation lengths



# Percentage deviation of data with simulations: Shower profile

X <sub>0</sub> Energy (GeV)	0	1	2	3	4	5	6	8
1	1.6	12.7	19.4	18.6	26.3	26.0	28.0	28.3
2	2.4	0.1	4.5	4.2	10.6	18.6	19.1	26.0
3	9.4	17.1	11.3	6.1	3.7	1.6	6.6	17
4	3.7	15.3	3.9	10.7	5.9	0.2	1.3	11.9
5	23.8	21.3	8.9	18.0	12.3	4.6	7.7	7.9